

Supporting Information

Quantitative Estimation of Exciton Quenching Strength at Interface of Charge Injection layers and Organic Semiconductor

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This file includes the following information:

Figures S1 to S7 and Table S1.

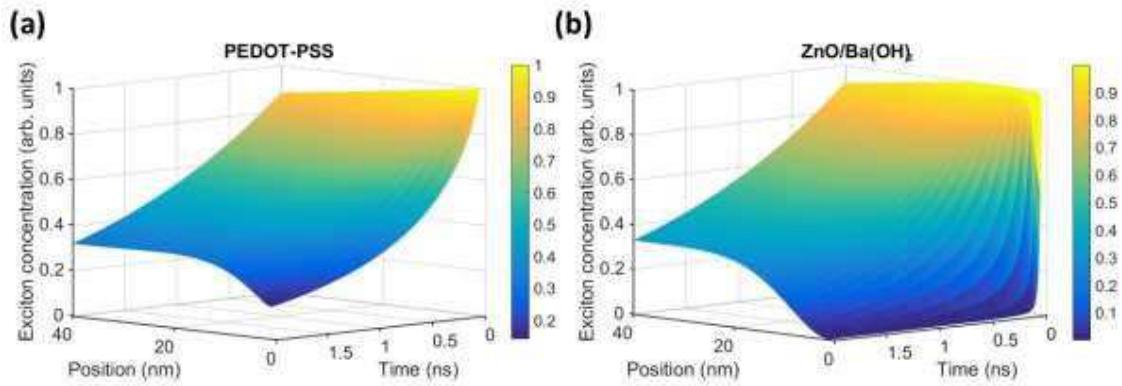


Figure S1 Simulated normalized spatio-temporal profile of exciton density inside F8BT layer with (a) PEDOT:PSS and (b) ZnO/Ba(OH)₂ as injection layer.

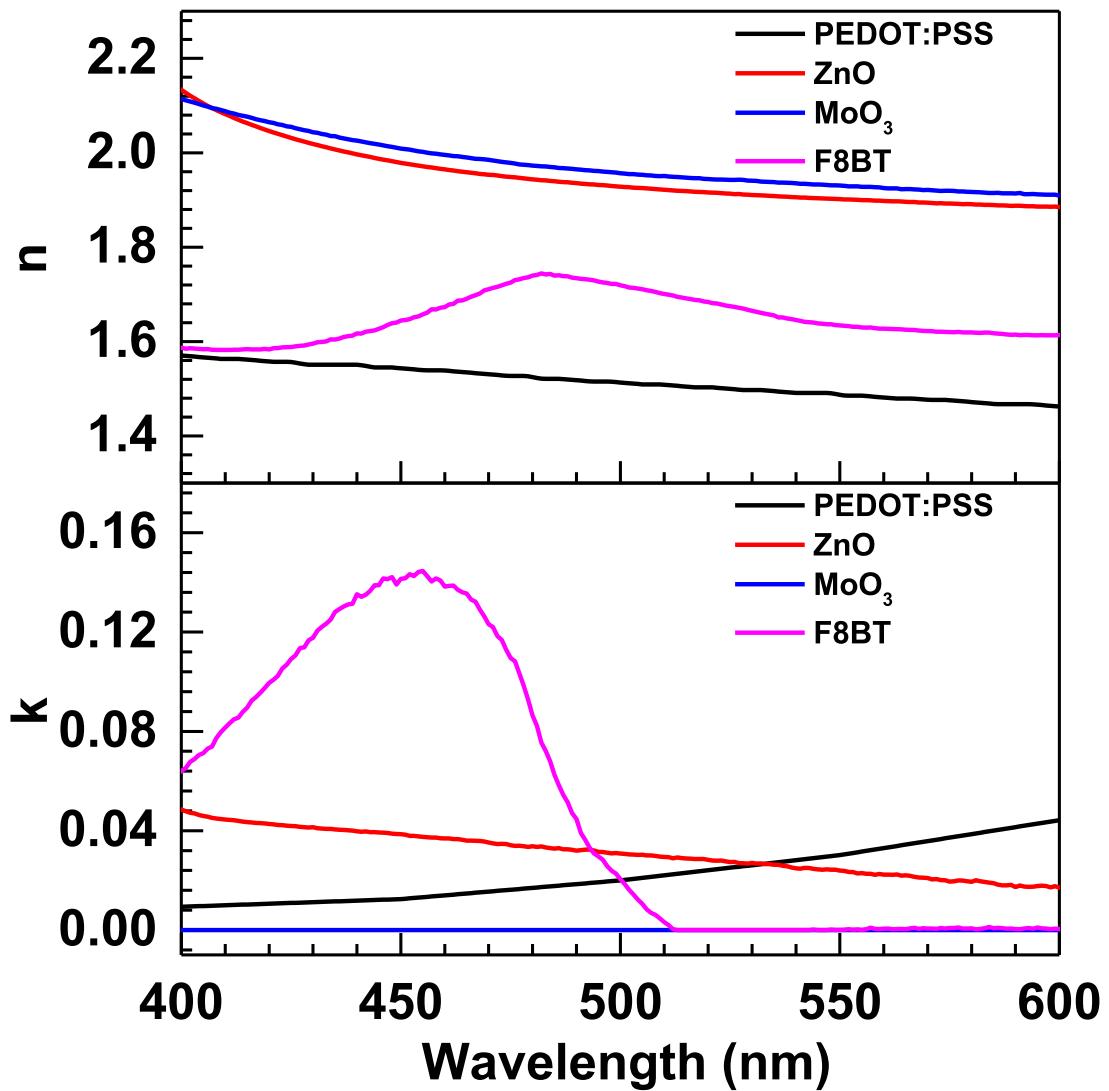


Figure S2 (a) Real (n) and (b) imaginary (k) parts of refractive index versus wavelength for PEDOT:PSS (black solid line), ZnO (Red solid line), MoO₃ (blue solid line) and F8BT (pink solid line) layer.

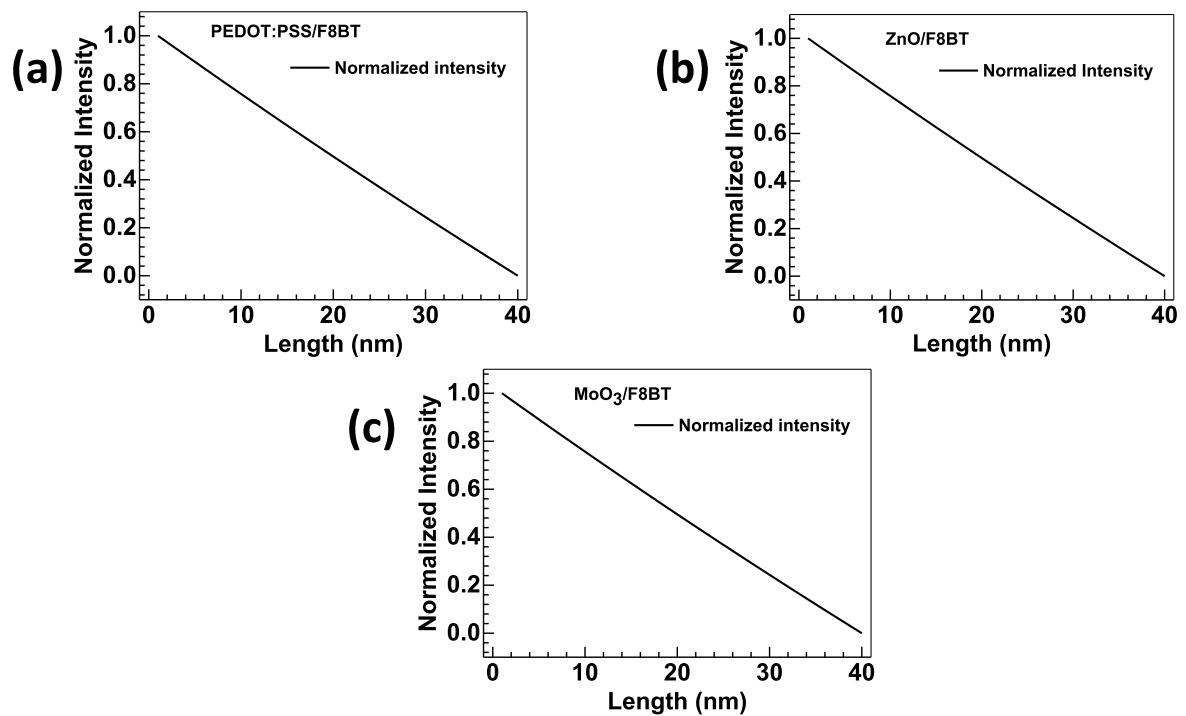


Figure S3 Initial spatial normalized exciton concentration profile for (a) PEDOT:PSS/F8BT, (b) ZnO/F8BT and (c) MoO₃/F8BT layer system with excitation wavelength of 440nm.

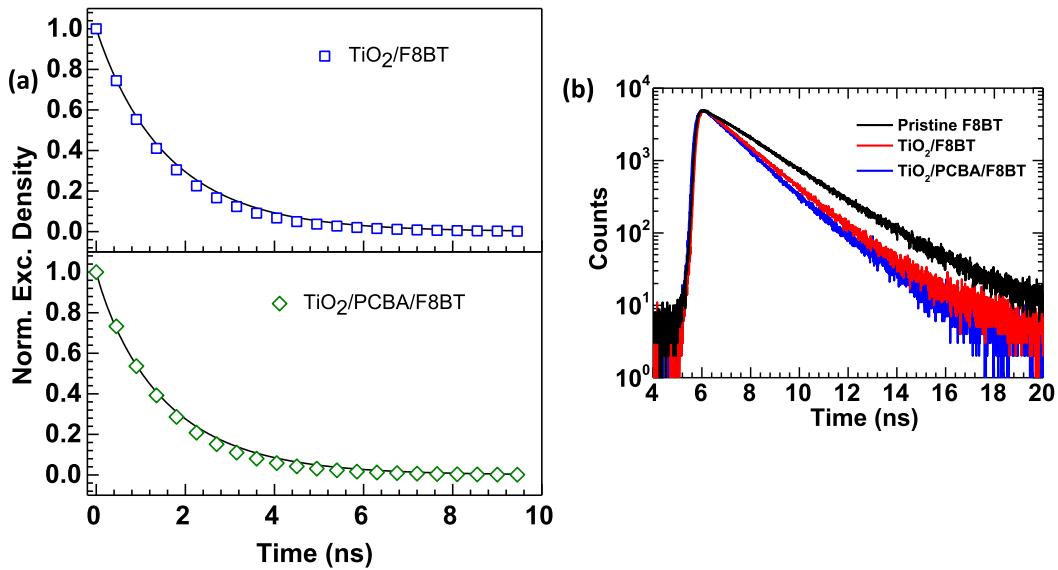


Figure S4: Transient PL decay for (a) $\text{TiO}_2/\text{F8BT}$ and $\text{TiO}_2/\text{PCBA}/\text{F8BT}$ system at emission wavelength of 540nm. Excitation wavelength is 440nm pulsed diode laser. Solid line is fit to experimental data using Eq.4. (b) TCSPC data in semi-log style for pristine F8BT, $\text{TiO}_2/\text{PCBA}/\text{F8BT}$ and $\text{TiO}_2/\text{F8BT}$ films on quartz substrates.

Table S1: PL Decay time and corresponding capture radii (x_0) for $\text{TiO}_2/\text{F8BT}$, $\text{TiO}_2/\text{PCBA}/\text{F8BT}$ interfaces.

Quencher	Decay time (ns)	x_0 (nm)
$\text{TiO}_2/\text{F8BT}$	1.5	3.02
$\text{TiO}_2/\text{PCBA}/\text{F8BT}$	1.42	3.56

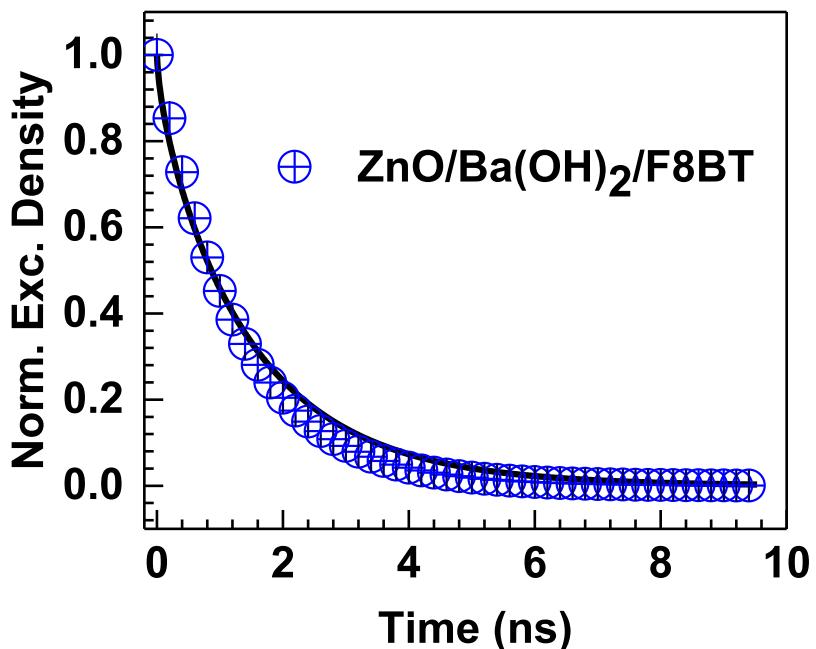


Figure S5: Transient PL decay for $\text{ZnO}/\text{Ba}(\text{OH})_2/\text{F8BT}$ at peak emission wavelength of 540nm. Excitation wavelength is 440nm pulsed diode laser. Solid line is fit to experimental data using Eq.4.

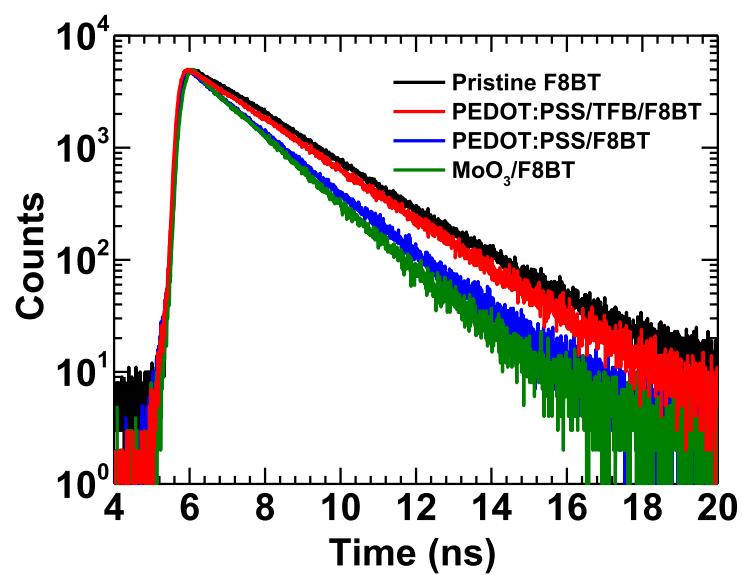


Figure S6. TCSPC data for pristine F8BT, PEDOT:PSS/F8BT, PEDOT:PSS/TFB/F8BT and MoO₃/F8BT films on quartz substrates.

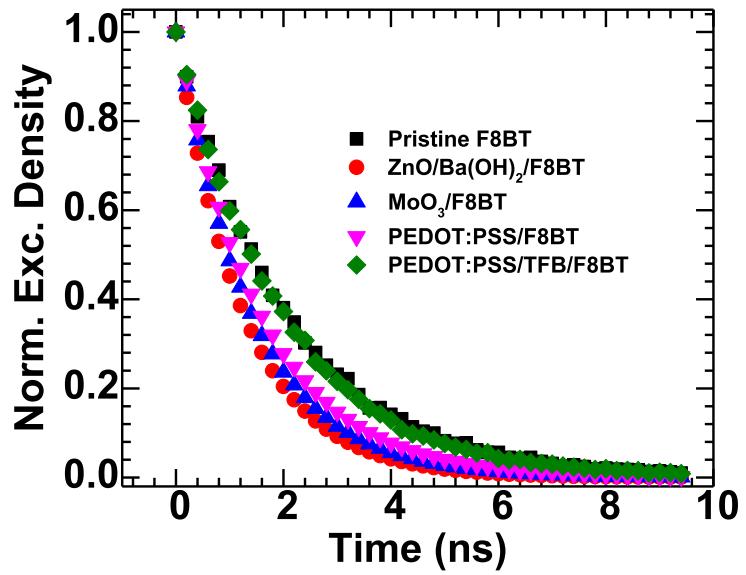


Figure S7. Normalized Excitonic Density profiles for Pristine F8BT and F8BT with Charge injection layers.